Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 119330			APPLICATION NO. 10/814,169			
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U.S. PATENT DOCUMENTS										
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AN /	1	OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)  "Single Crystal Thin Film Transistors", IBM Technical Disclosure Bulletin, Aug. 1993, p. 257.								
	2	R. Ishihara et al., "Advanced Excimer-Laser Crystallization Techniques of Si Thin-Film For Loacation Control of Large Grain on Glass", proc. SPIE 2001, Vol. 4295, pp. 14-23.								
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Date: August 3, 2004